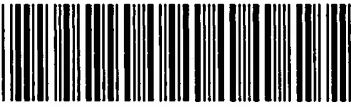


Search Notes 	Application/Control No. 10526660	Applicant(s)/Patent Under Reexamination TANAKA ET AL.
	Examiner Cho, Jennifer Y	Art Unit 1621

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	8/28/07	JC
STIC Search	8/10/07	HM
STN Search	8/28/07	JC
STN Search	8/28/07	SB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
East Text Search of 560/61 and 514/543		8/29/07	JC